Se	earch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/811,974	TANI ET AL.	
Examiner	Art Unit	
John P. Leubecker	3739	

	SEAR	CHED	
Class	Subclass	Date	Examiner
600	109,118	8/28/2006	JPL
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